## Notice of References Cited

Application/Control No. 10/541,874	Reexaminati	Applicant(s)/Patent Under Reexamination BENVENUTI ET AL.		
Examiner	Art Unit			
Laura M. Lee	3724	Page 1 of 1		

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-4,033,862	07-1977	Spencer, Harvey J.	209/617
*	В	US-2003/0015077	01-2003	Betti et al.	83/100
*	С	US-5,475,917	12-1995	Biagiotti, Guglielmo	29/822
*	D	US-2004/0020343	02-2004	Gambini, Giovanni	83/869
*	E	US-2001/0022285	09-2001	Gambini, Giovanni	209/698
*	F	US-2003/0167887	09-2003	Butterworth, Tad T.	83/27
*	G	US-6,332,527	12-2001	Wierschke, Larry D.	198/369.7
*	Н	US-4,977,803	12-1990	Blom, Lawrence E.	83/23
*		US-4,462,287	07-1984	Weis et al.	83/104
	7	US-			
	K	US-			
	L	US-			
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	EP1231320A2	08-2002	European Patent	Progetti et al.	D21B 1/10
	0	EP0668132A1	08-1995	European Patent	Wunderlich, Gary	B26D 7/18
	Р					
	Q	·				
	R					
	S				•	
	T					

## NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)	
	U		·
	V		-
	w		•
	x		

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.